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C3M0032120K

Silicon Carbide Power MOSFET C3M[™] MOSFET Technology

N-Channel Enhancement Mode

Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- Solar inverters
- EV motor drive
- High voltage DC/DC converters
- Switched mode power supplies
- Load switch

Part Number	Package	Marking		
C3M0032120K	TO 247-4	C3M0032120K		

Maximum Ratings (T_c = 25 °C unless otherwise specified)

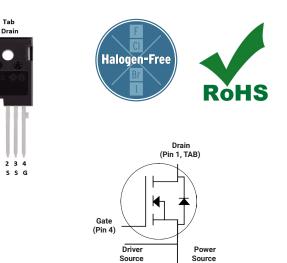
Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1200	V	V_{GS} = 0 V, I _D = 100 µA	
V_{GSmax}	Gate - Source Voltage (dynamic)	-8/+19	V	AC (f >1 Hz)	Note 1
V_{GSop}	Gate - Source Voltage (static)	-4/+15	V	Static	Note 2
	Continuous Drain Current	63	A	V _{GS} = 15 V, T _c = 25°C	— Fig. 19
Ι _D		48	A	V _{GS} = 15 V, T _c = 100°C	- Fig. 19
I _{D(pulse)}	Pulsed Drain Current	120	А	Pulse width t_P limited by T_{jmax}	
P _D	Power Dissipation	283	W	T _c =25°C, T _J = 175 °C	Fig. 20
T _J , T _{stg}	Operating Junction and Storage Temperature	-40 to +175	°C		
Τ _L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	

Note (1): When using MOSFET Body Diode V_{GSmax} = -4V/+19VNote (2): MOSFET can also safely operate at 0/+15 V

20K Power MOSEET

V_{DS} 1200 V I_D@25°c 63 A R_{DS(on)} 32 mΩ

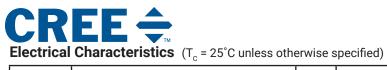
Package



(Pin 3)

(Pin 2)

1



Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V}, I_{D} = 100 \mu\text{A}$	
M		1.8	2.5	3.6	V	V _{DS} = V _{GS} , I _D = 11.5 mA	Fig. 11
$V_{\text{GS(th)}}$	Gate Threshold Voltage		2.0		V	V _{DS} = V _{GS} , I _D = 11.5 mA, T _J = 175°C	Fig. 11
IDSS	Zero Gate Voltage Drain Current		1	50	μA	V_{DS} = 1200 V, V_{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	250	nA	V _{GS} = 15 V, V _{DS} = 0 V	
D	Drain-Source On-State Resistance	23	32	43	mΩ	V _{GS} = 15 V, I _D = 40 A	Fig. 4,
$R_{DS(on)}$			57.6			V_{GS} = 15 V, I _D = 40 A, T _J = 175°C	5, 6
a	Transconductance		27		s	V _{DS} = 20 V, I _{DS} = 40 A	Fig. 7
g _{fs}	Tansconductance		22			V_{DS} = 20 V, I_{DS} = 40 A, T_{J} = 175°C	
C_{iss}	Input Capacitance		3357			V _{GS} = 0 V, V _{DS} = 1000 V f = 100 kHz	Fig. 17, 18
Coss	Output Capacitance		129		pF		
Crss	Reverse Transfer Capacitance		8			$V_{AC} = 25 \text{ mV}$	
Eoss	Coss Stored Energy	i i	76		μJ		Fig. 16
Eon	Turn-On Switching Energy (SiC Diode FWD)		367		μJ	V_{DS} = 800 V, V_{GS} = -4 V/+15 V, I_{D} = 40 A,	Fig. 26
EOFF	Turn Off Switching Energy (SiC Diode FWD)		123			R _{G(ext)} = 2.5Ω, L= 65.7 μH, Tj = 175°C	Fig. 20
E _{ON}	Turn-On Switching Energy (Body Diode FWD)		955			$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/+15 \text{ V}, I_{D} = 40 \text{ A},$	Fig. 0 (
EOFF	Turn Off Switching Energy (Body Diode FWD)		107		μJ	R _{G(ext)} = 2.5Ω, L= 65.7 μH, Tj = 175°C	Fig. 26
t _{d(on)}	Turn-On Delay Time		25				
tr	Rise Time		18			$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	Fig. 27
$t_{d(off)}$	Turn-Off Delay Time		32		ns	s $R_{G(ext)} = 2.5 \Omega$, $I_D = 40$ A, L= 65.7 Timing relative to V_{DS} , Inductive load	Fig. 27
t _f	Fall Time		9		1		
R _{G(int)}	Internal Gate Resistance		1.7		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		40			V _{DS} = 800 V, V _{GS} = -4 V/15 V	Ì
Q_{gd}	Gate to Drain Charge		34		nC	$I_{\rm D} = 40 {\rm A}$	Fig. 12
Qg	Total Gate Charge		118	7		Per IEC60747-8-4 pg 21	

2

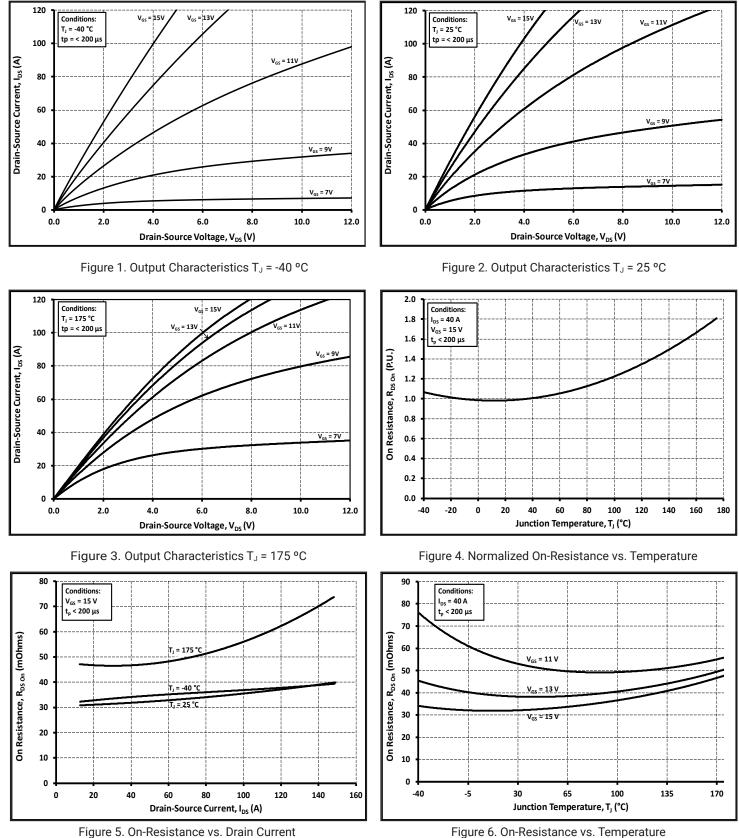
Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V _{SD}	Diode Forward Voltage	4.6		V	V _{GS} = -4 V, I _{SD} = 20 A, T _J = 25 °C	Fig. 8,
V SD	Diode Forward Voltage	4.2		V	V _{GS} = -4 V, I _{SD} = 20 A, T _J = 175 °C	9, 10
Is	Continuous Diode Forward Current		62	А	$V_{_{\rm GS}}$ = -4 V, $T_{\rm c}$ = 25°C	Note 1
I _{S, pulse}	Diode pulse Current		120	А	$V_{_{GS}}$ = -4 V, pulse width t _P limited by T _{jmax}	Note 1
t _{rr}	Reverse Recover time	27		ns		
Q _{rr}	Reverse Recovery Charge	478		nC	V _{GS} = -4 V, I _{SD} = 40 A, V _R = 800 V dif/dt = 2250 A/µs, T₁ = 175 °C	Note 1
I _{rrm}	Peak Reverse Recovery Current	27		А		

Thermal Characteristics

Symbol Parameter		Тур.	Unit	Test Conditions	Note
R _{eJC}	R _{0JC} Thermal Resistance from Junction to Case				5. 01
R _{0JA}	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21



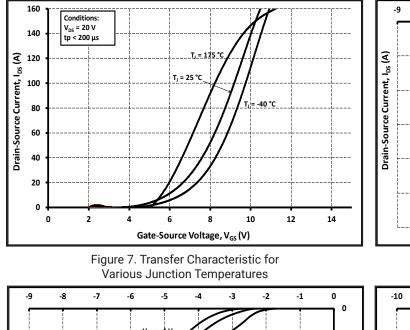


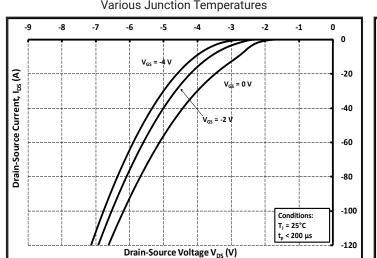
For Various Gate Voltage

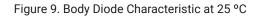
For Various Temperatures

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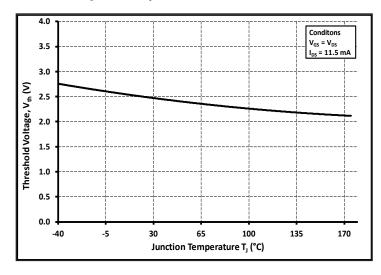
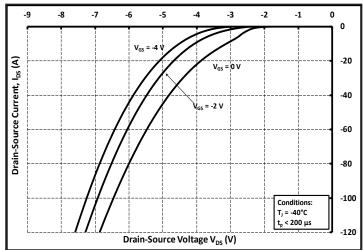


Figure 11. Threshold Voltage vs. Temperature





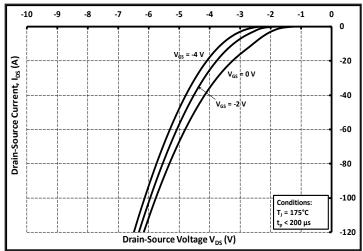
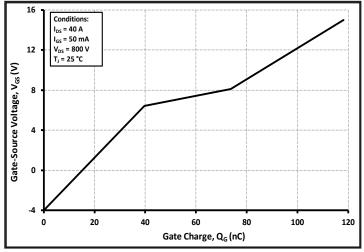


Figure 10. Body Diode Characteristic at 175 °C





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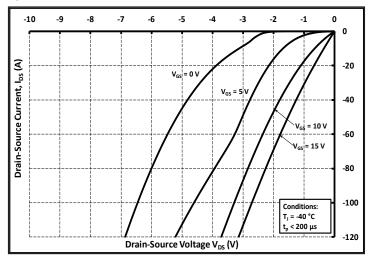


Figure 13. 3rd Quadrant Characteristic at -40 °C

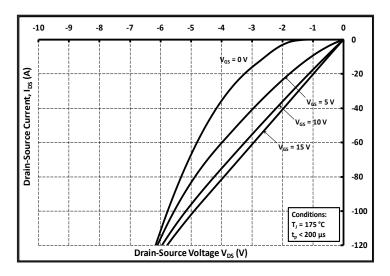
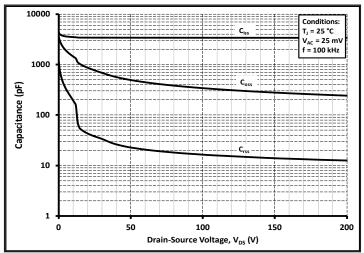
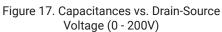
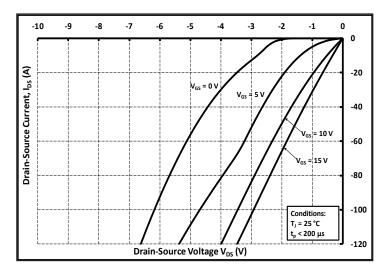


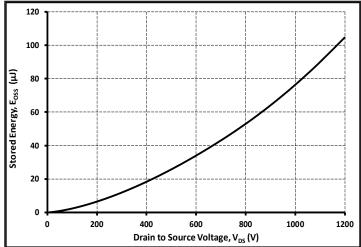
Figure 15. 3rd Quadrant Characteristic at 175 °C

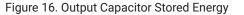












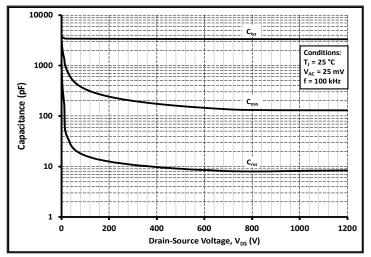
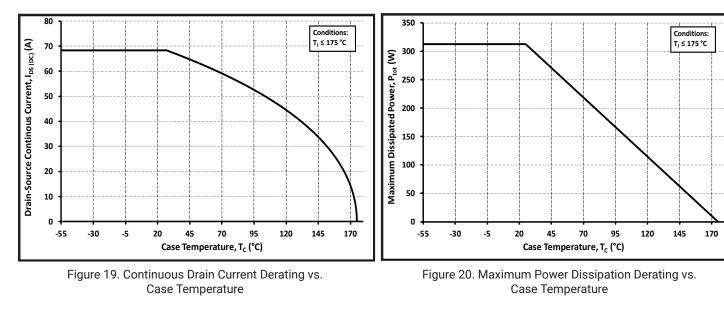
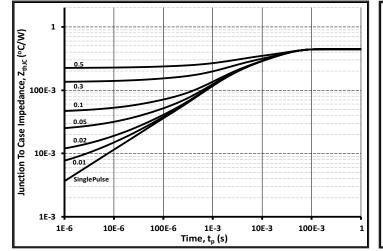


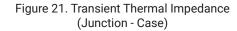
Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)

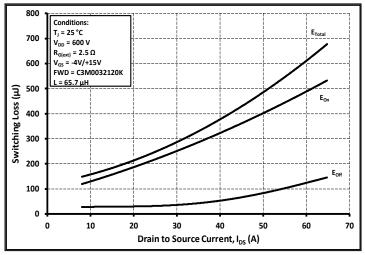
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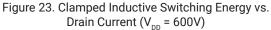


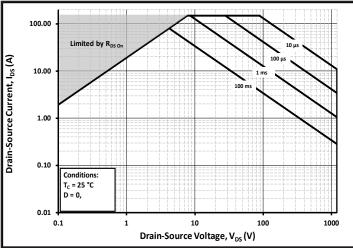


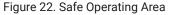


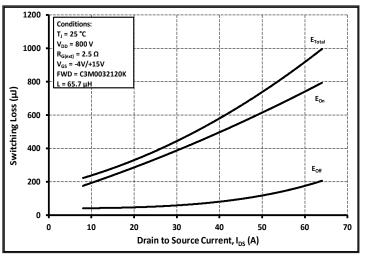


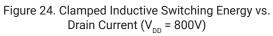














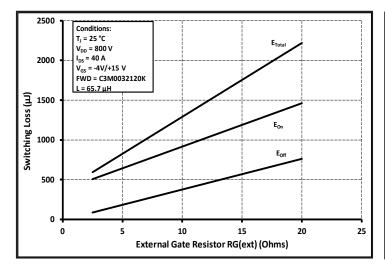


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

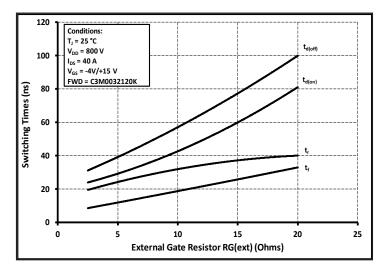


Figure 27. Switching Times vs. R_{G(ext)}

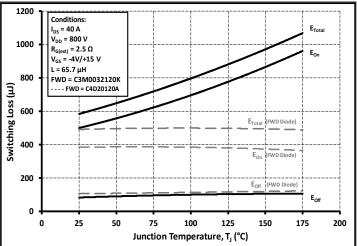


Figure 26. Clamped Inductive Switching Energy vs. Temperature

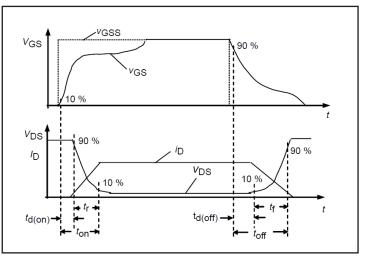


Figure 28. Switching Times Definition

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Test Circuit Schematic

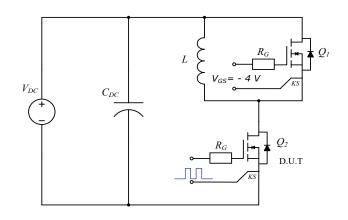


Figure 29. Clamped Inductive Switching Waveform Test Circuit

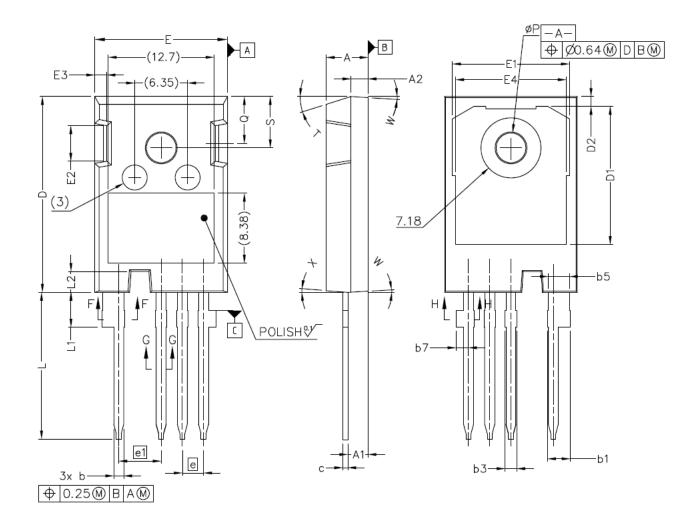
Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

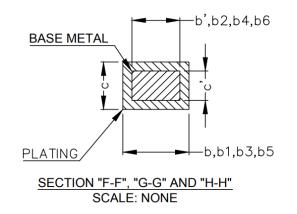
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Package Dimensions

Package TO-247-4L





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Package Dimensions

Package TO-247-4L

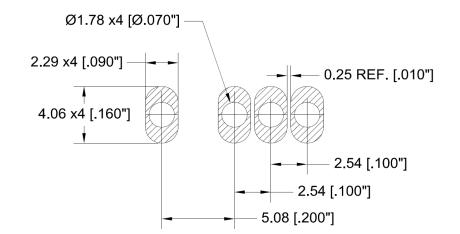
NOTE;

- 1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT
- 2. DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.
- 3. ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES. 4 'N' IS THE NUMBER OF TERMINAL POSITIONS

4.	IN	12	I TE NUMBER	UГ	IERMINAL POSITIO

SYM	MILLIN	1 ETERS
51101	MIN	MAX
Α	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b`	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
b7	1.30	1.70
c`	0.55	0.65
С	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13

SYM	MILLIM	1ETERS			
51101	MIN	MAX			
E1	13.10	14.15			
E2	3.68	5.10			
E3	1.00	1.90			
E4	12.38	13.43			
е	2.54	BSC			
e1	5.08	BSC			
N*	4				
L	17.31	17.82			
L1	3.97	4.37			
L2	2.35	2.65			
ØР	3.51	3.65			
Q	5.49	6.00			
S	6.04	6.30			
Т	17.5° REF.				
W	3.5° REF.				
Х	4° REF.				





Notes

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/ EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.

REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

Related Links

- SPICE Models: http://wolfspeed.com/power/tools-and-support
- SiC MOSFET Isolated Gate Driver reference design: http://wolfspeed.com/power/tools-and-support
- SiC MOSFET Evaluation Board: http://wolfspeed.com/power/tools-and-support

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